

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

TAKANO, KENICHI

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
Updated		5/4/2007	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR